## Notic of References Cited Application/Control No. 10/076,600 Applicant(s)/Patent Under Reexamination WU, CHI Examiner Brian M. Healy Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,377,716 B1	04-2002	Veldhuis et al.	385/1
	В	US-5,889,898 A	03-1999	Koren et al.	385/9
	С	US-5,706,374	01-1998	Vinchant, Jean-Francois	385/16
	D	US-2003/0067676 A1	04-2003	Wang et al.	359/344
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	٧					
	W					
	X					

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